



RF LDMOS Wideband Integrated Power Amplifiers

The MW6IC1940NB/GNB wideband integrated circuit is designed with on-chip matching that makes it usable from 1920 to 2000 MHz. This multi-stage structure is rated for 26 to 32 Volt operation and covers all typical cellular base station modulation formats.

Final Application

- Typical 2-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ1} = 200$ mA, $I_{DQ2} = 440$ mA, $P_{out} = 4.5$ Watts Avg., Full Frequency Band (1920-2000 MHz), Channel Bandwidth = 3.84 MHz, PAR = 8.5 dB @ 0.01% Probability on CCDF.
 - Power Gain — 28.5 dB
 - Power Added Efficiency — 13.5%
 - IM3 @ 10 MHz Offset — -43 dBc in 3.84 MHz Bandwidth
 - ACPR @ 5 MHz Offset — -46 dBc in 3.84 MHz Bandwidth

Driver Applications

- Typical 2-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ1} = 200$ mA, $I_{DQ2} = 350$ mA, $P_{out} = 26$ dBm, Full Frequency Band (1920-2000 MHz), Channel Bandwidth = 3.84 MHz, PAR = 8.5 dB @ 0.01% Probability on CCDF.
 - Power Gain — 27 dB
 - IM3 @ 10 MHz Offset — -59 dBc in 3.84 MHz Bandwidth
 - ACPR @ 5 MHz Offset — -62 dBc in 3.84 MHz Bandwidth
- Capable of Handling 3:1 VSWR, @ 28 Vdc, 1960 MHz, 40 Watts CW Output Power
- Stable into a 3:1 VSWR. All Spurs Below -60 dBc @ 100 mW to 20 W CW P_{out} .

Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source Scattering Parameters
- On-Chip Matching (50 Ohm Input, DC Blocked, >3 Ohm Output)
- Integrated Quiescent Current Temperature Compensation with Enable/Disable Function
- Integrated ESD Protection
- 200°C Capable Plastic Package
- Designed for Lower Memory Effects and Wide Instantaneous Bandwidth Applications
- RoHS Compliant
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel.

MW6IC1940NBR1
MW6IC1940GNBR1

1920-2000 MHz, 40 W, 28 V
2 x W-CDMA
RF LDMOS WIDEBAND
INTEGRATED POWER AMPLIFIERS

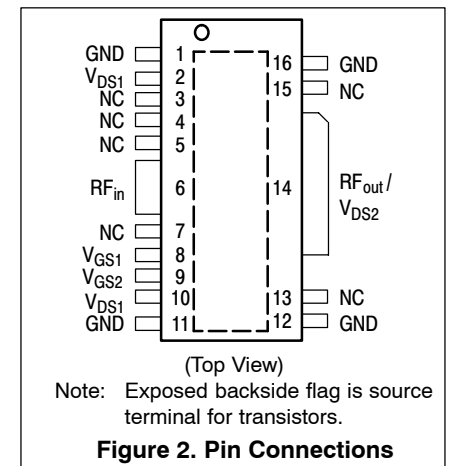
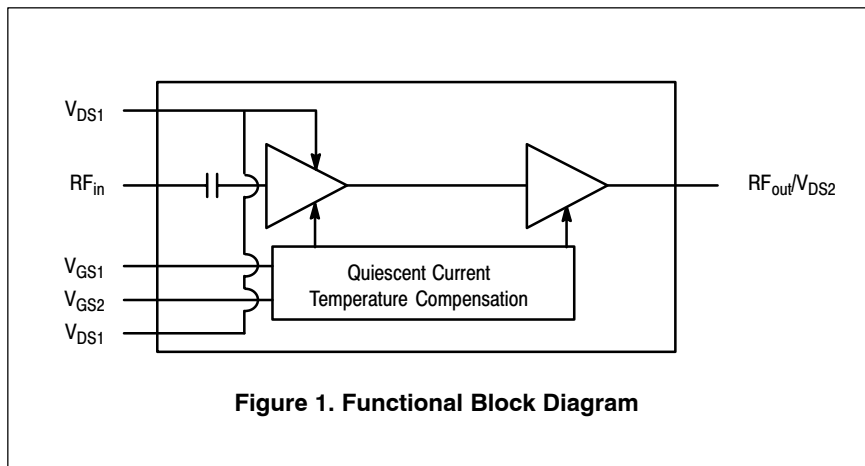
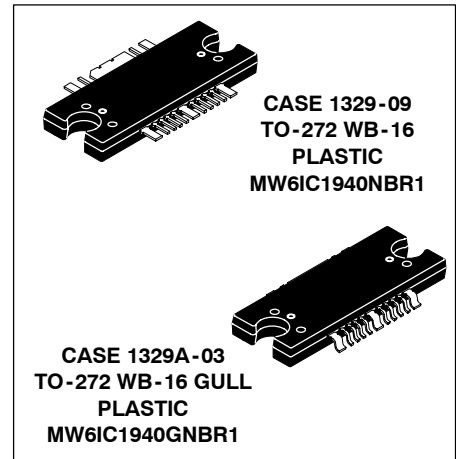


Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|--------------------------------|-----------|-------------|------|
| Drain-Source Voltage | V_{DSS} | -0.5, +68 | Vdc |
| Gate-Source Voltage | V_{GS} | -0.5, +6 | Vdc |
| Storage Temperature Range | T_{stg} | -65 to +200 | °C |
| Operating Junction Temperature | T_J | 200 | °C |
| Input Power | P_{in} | 20 | dBm |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value ⁽¹⁾ | Unit |
|---|-----------------|-------------------------------------|------|
| Thermal Resistance, Junction to Case W-CDMA Application ($P_{out} = 4.5$ W Avg.) | $R_{\theta JC}$ | 2.1 1.2 | °C/W |
| | | Stage 1, 28 Vdc, $I_{DQ1} = 200$ mA | |
| | | Stage 2, 28 Vdc, $I_{DQ2} = 440$ mA | |

Table 3. ESD Protection Characteristics

| Test Methodology | Class |
|---------------------------------------|--------------|
| Human Body Model (per JESD22-A114) | 1B (Minimum) |
| Machine Model (per EIA/JESD22-A115) | A (Minimum) |
| Charge Device Model (per JESD22-C101) | IV (Minimum) |

Table 4. Moisture Sensitivity Level

| Test Methodology | Rating | Package Peak Temperature | Unit |
|---------------------------------------|--------|--------------------------|------|
| Per JESD 22-A113, IPC/JEDEC J-STD-020 | 3 | 260 | °C |

Table 5. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

Functional Tests (In Freescale Wideband 1920-2000 MHz Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1} = 200$ mA, $I_{DQ2} = 440$ mA, $P_{out} = 4.5$ W Avg., $f_1 = 1922.5$ MHz, $f_2 = 1932.5$ MHz and $f_1 = 1987.5$ MHz, $f_2 = 1997.5$ MHz, 2-Carrier W-CDMA, 3.84 MHz Channel Bandwidth @ ± 5 MHz Offset. IM3 measured in 3.84 MHz Channel Bandwidth @ ± 10 MHz Offset. PAR = 8.5 dB @ 0.01% Probability on CCDF.

| | | | | | |
|------------------------------|----------|------|------|------|-----|
| Power Gain | G_{ps} | 26 | 28.5 | 31.5 | dB |
| Power Added Efficiency | PAE | 12.5 | 13.5 | — | % |
| Intermodulation Distortion | IM3 | — | -43 | -40 | dBc |
| Adjacent Channel Power Ratio | ACPR | — | -46 | -43 | dBc |
| Input Return Loss | IRL | — | -15 | -10 | dB |

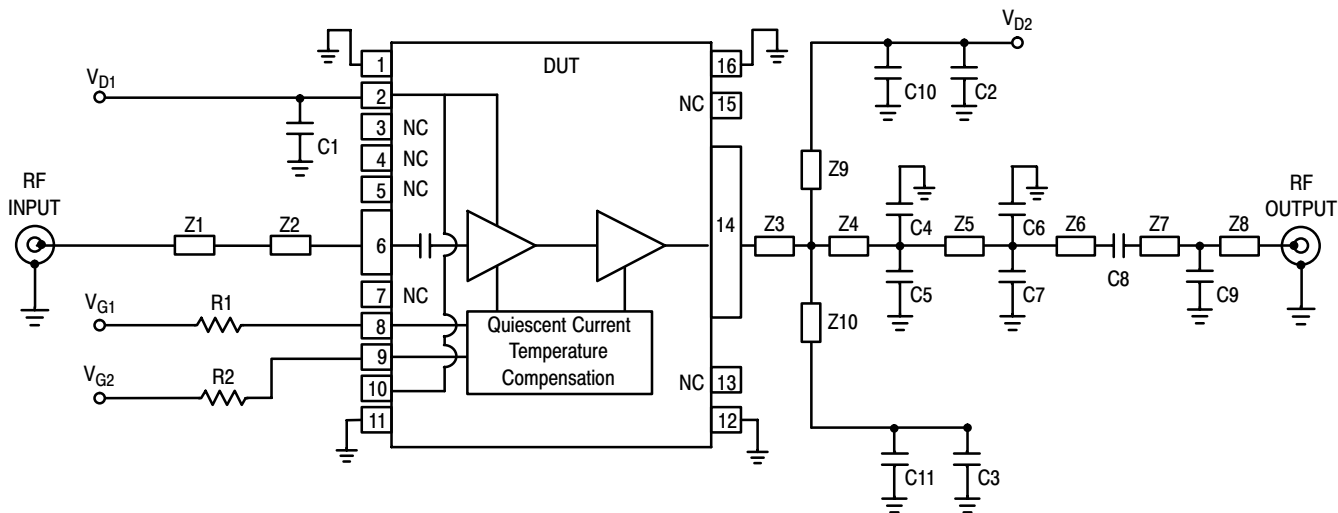
Typical Performances (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1} = 210$ mA, $I_{DQ2} = 370$ mA, 1920-2000 MHz

| | | | | | |
|--|-----------------|---|----------|---|-----|
| Video Bandwidth @ 40 W PEP P_{out} where IM3 = -30 dBc (Tone Spacing from 100 kHz to VBW) $\Delta\text{IMD3} = \text{IMD3} @ \text{VBW}$ frequency - IMD3 @ 100 kHz < 1 dBc (both sidebands) | VBW | — | 30 | — | MHz |
| Quiescent Current Accuracy over Temperature with 18 k Ω Gate Feed Resistors (-10 to 85°C) ⁽²⁾ | ΔI_{QT} | — | ± 5 | — | % |
| Gain Flatness in 30 MHz Bandwidth @ $P_{out} = 1$ W CW | G_F | — | 0.75 | — | dB |
| Average Deviation from Linear Phase in 30 MHz Bandwidth @ $P_{out} = 1$ W CW | Φ | — | ± 1 | — | ° |
| Average Group Delay @ $P_{out} = 1$ W CW Including Output Matching | Delay | — | 2.5 | — | ns |
| Part-to-Part Insertion Phase Variation @ $P_{out} = 1$ W CW, Six Sigma Window | $\Delta\Phi$ | — | ± 10 | — | ° |

Typical Performances (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1} = 240$ mA, $I_{DQ2} = 440$ mA, 1920-2000 MHz

| | | | | | |
|---|-----------|---|----|---|---|
| Saturated Pulsed Output Power (12 μsec (on), 1% Duty Cycle) | P_{sat} | — | 60 | — | W |
|---|-----------|---|----|---|---|

1. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>.
Select Documentation/Application Notes - AN1955.
2. Refer to AN1977, *Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family*. Go to <http://www.freescale.com/rf>.
Select Documentation/Application Notes - AN1977.



| | | | |
|-----|--------------------------|---------|--|
| Z1 | 2.20" x 0.09" Microstrip | Z7* | 0.98" x 0.082" Microstrip |
| Z2 | 0.13" x 0.04" Microstrip | Z8* | 0.76" x 0.082" Microstrip |
| Z3 | 0.17" x 0.41" Microstrip | Z9, Z10 | 0.08" x 0.079" Microstrip |
| Z4* | 0.20" x 0.41" Microstrip | PCB | Taconic TLX8-0300, 0.030", $\epsilon_r = 2.55$ |
| Z5* | 0.11" x 0.41" Microstrip | | |
| Z6* | 0.06" x 0.41" Microstrip | | |
| | | | * Variable for tuning |

Figure 3. MW6IC1940NBR1(GNBR1) Test Circuit Schematic

Table 6. MW6IC1940NBR1(GNBR1) Test Circuit Component Designations and Values

| Part | Description | Part Number | Manufacturer |
|----------------|--------------------------------------|-------------------|--------------|
| C1, C2, C3 | 2.2 μ F Chip Capacitors | C3225X5R1H225MT | TDK |
| C4, C5, C6, C7 | 0.5 pF Chip Capacitors | ATC100B0R5BT500XT | ATC |
| C8 | 1.5 pF Chip Capacitor | ATC100B1R5BT500XT | ATC |
| C9 | 0.2 pF Chip Capacitor | ATC100B0R2BT500XT | ATC |
| C10, C11 | 10 pF Chip Capacitors | ATC100B100JT500XT | ATC |
| R1 | 4.7 k Ω , 1/4 W Chip Resistor | CRCW12064701FKTA | Vishay |
| R2 | 3.3 k Ω , 1/4 W Chip Resistor | CRCW12063301FKTA | Vishay |

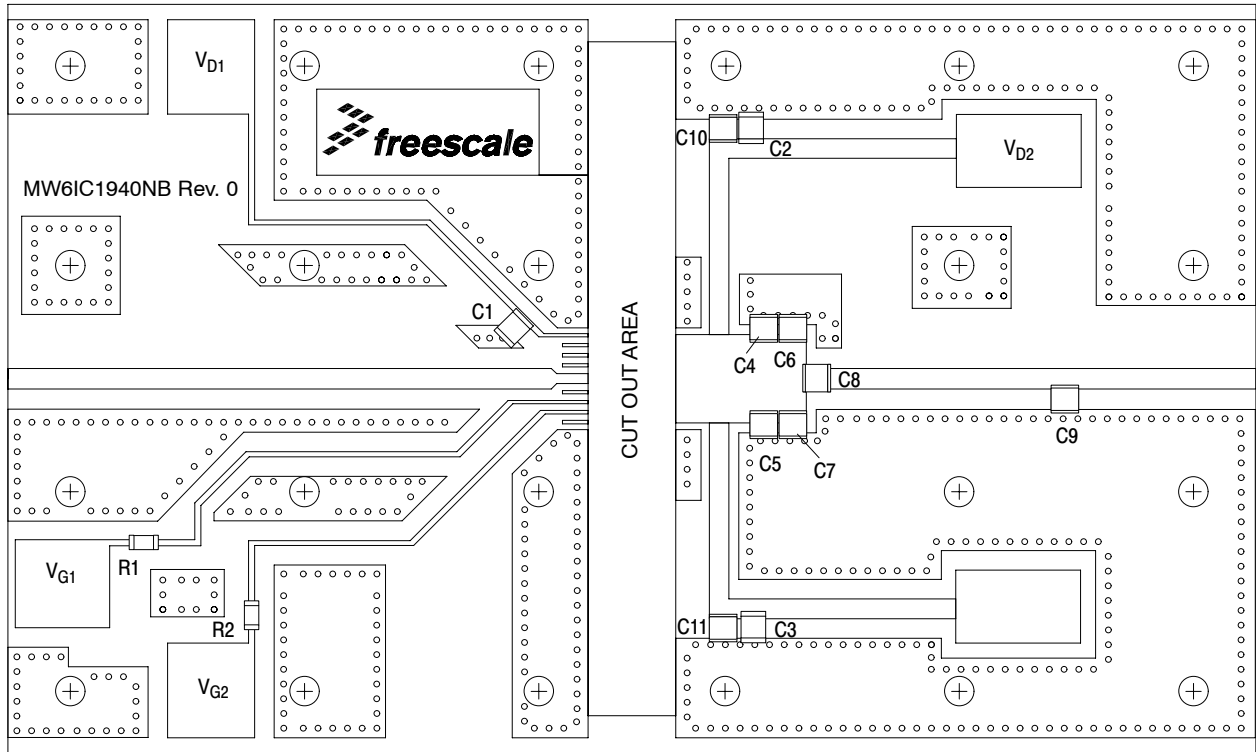


Figure 4. MW6IC1940NBR1(GNBR1) Test Circuit Component Layout

TYPICAL CHARACTERISTICS

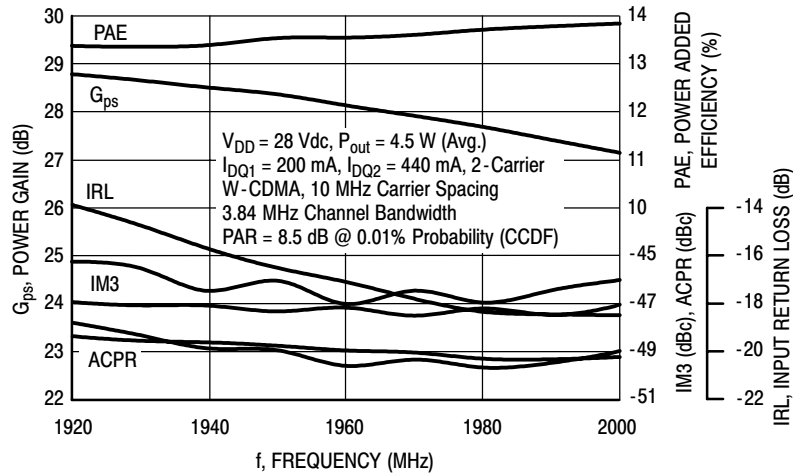


Figure 5. 2-Carrier W-CDMA Wideband Performance @ $P_{out} = 4.5$ Watts Avg.

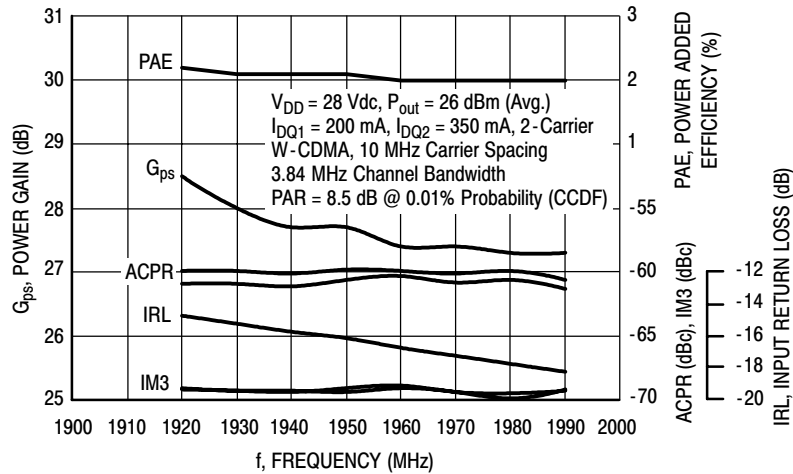


Figure 6. 2-Carrier W-CDMA Wideband Performance @ $P_{out} = 26$ dBm Avg.

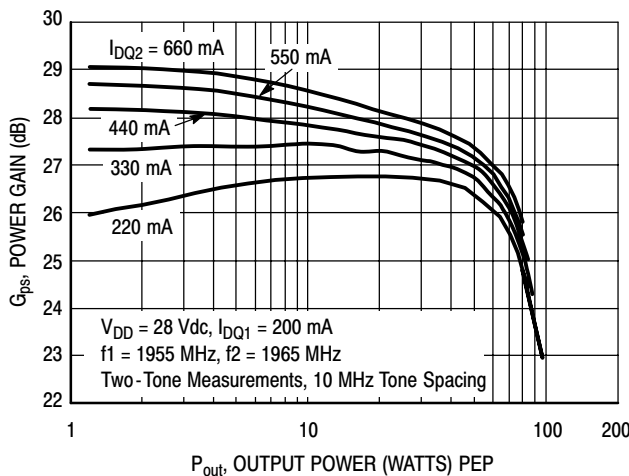


Figure 7. Two-Tone Power Gain versus Output Power @ $I_{DQ1} = 200$ mA

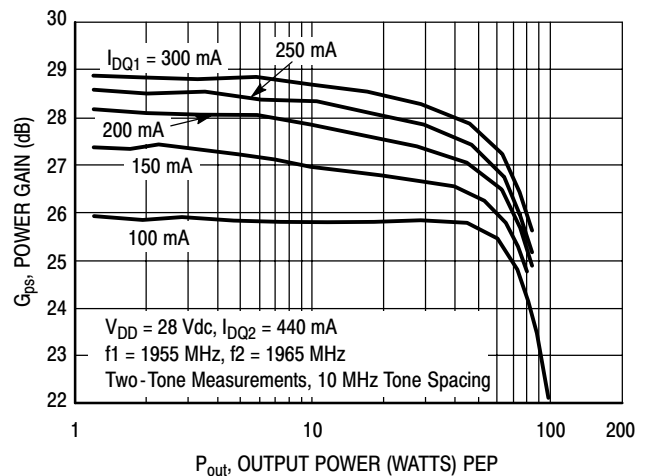


Figure 8. Two-Tone Power Gain versus Output Power @ $I_{DQ2} = 440$ mA

TYPICAL CHARACTERISTICS

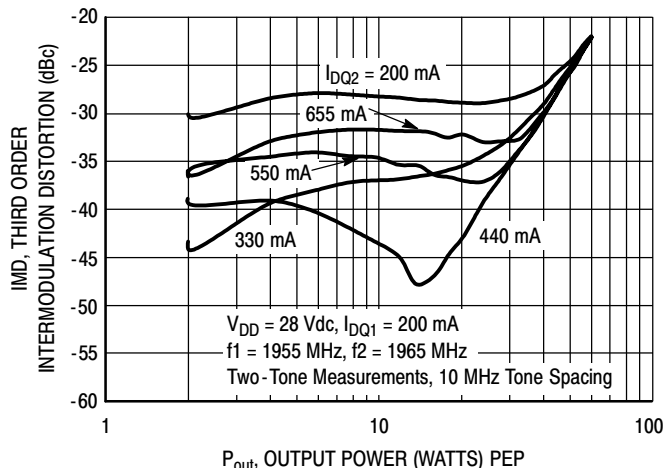


Figure 9. Third Order Intermodulation Distortion versus Output Power @ $I_{DQ1} = 200$ mA

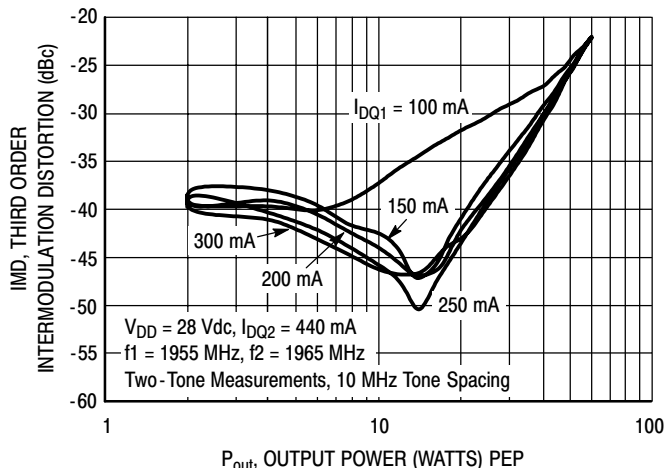


Figure 10. Third Order Intermodulation Distortion versus Output Power @ $I_{DQ2} = 440$ mA

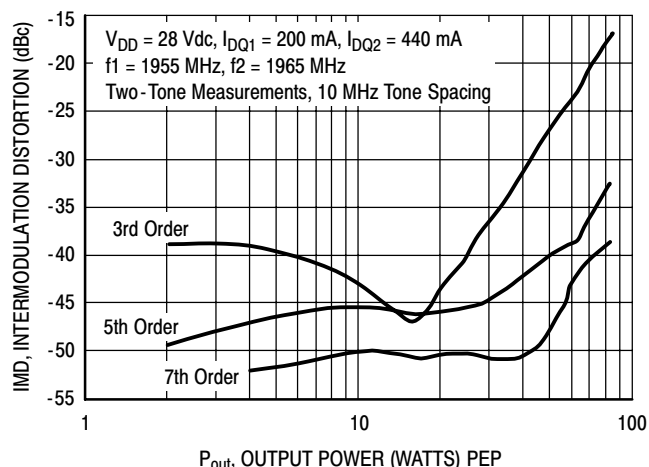


Figure 11. Intermodulation Distortion Products versus Output Power

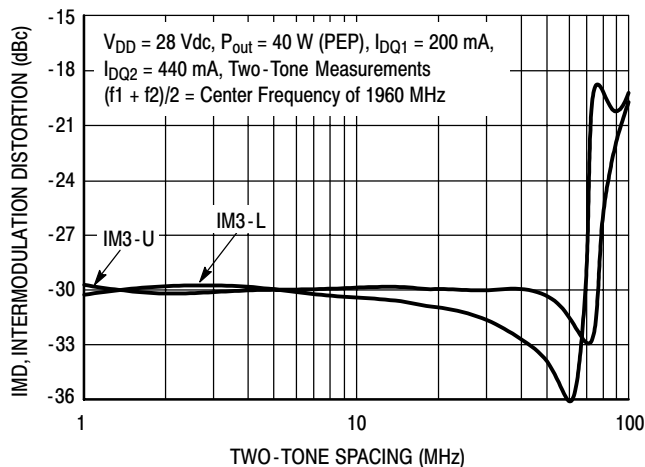


Figure 12. Intermodulation Distortion Products versus Tone Spacing

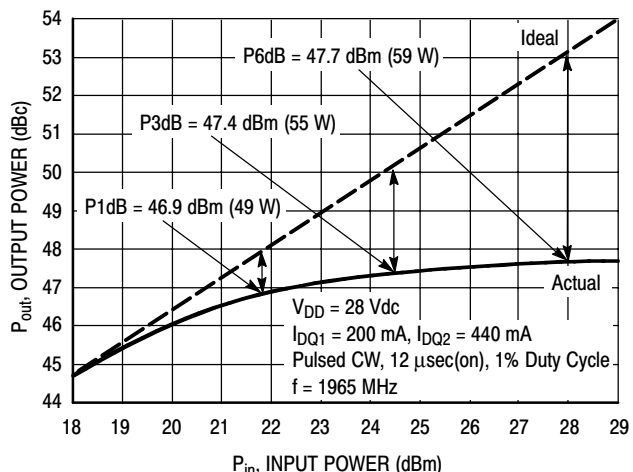


Figure 13. Pulsed CW Output Power versus Input Power

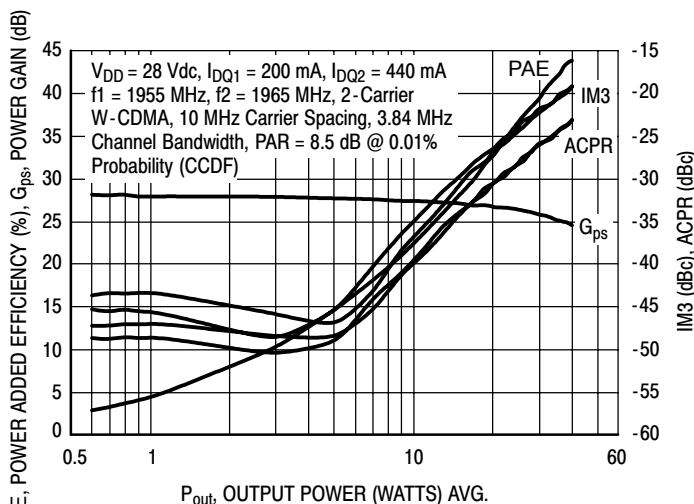


Figure 14. 2-Carrier W-CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power

TYPICAL CHARACTERISTICS

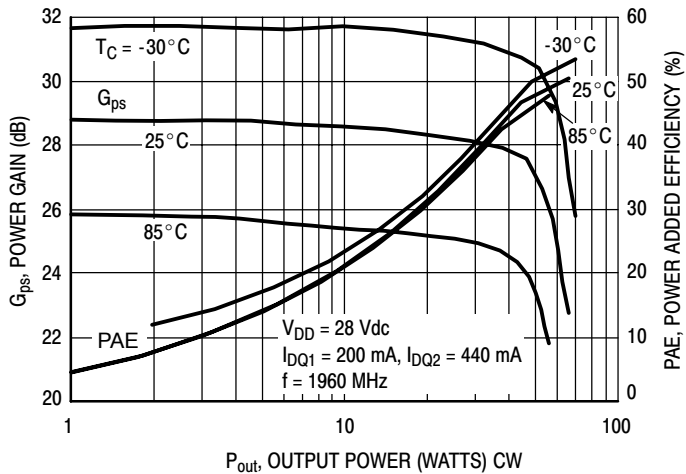


Figure 15. Power Gain and Power Added Efficiency versus Output Power

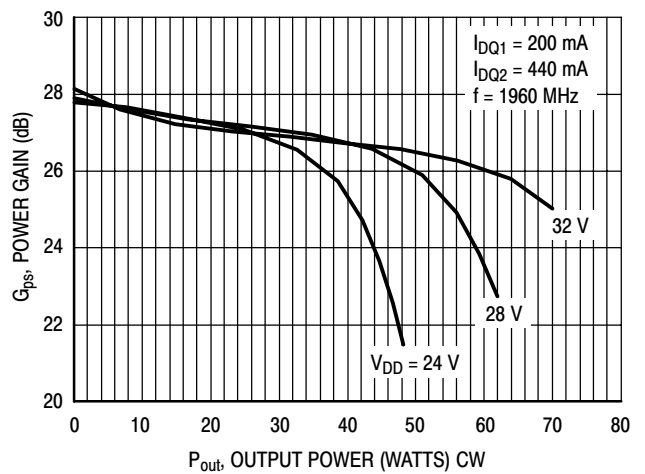


Figure 16. Power Gain versus Output Power

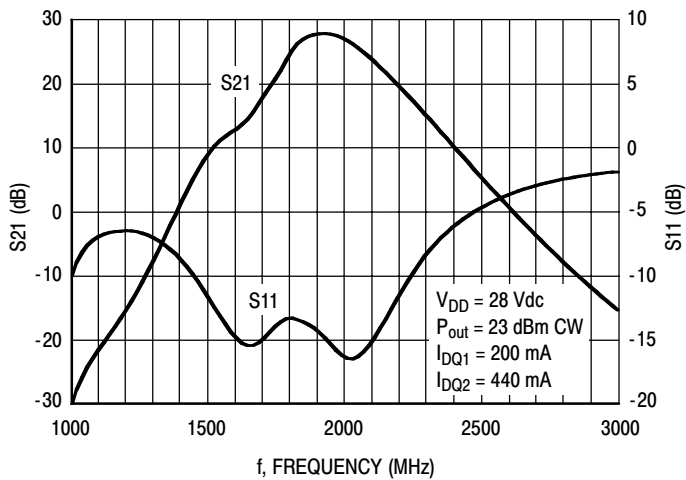


Figure 17. Broadband Frequency Response

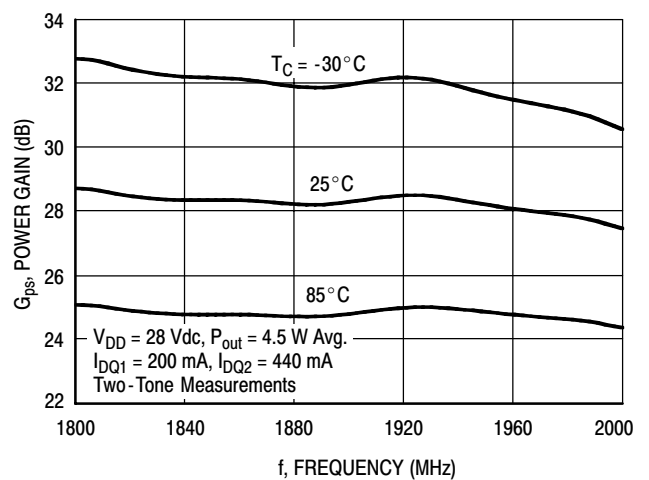
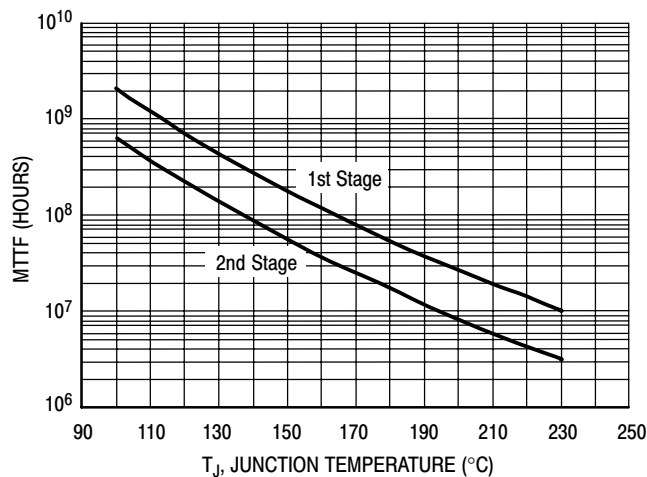


Figure 18. Power Gain versus Frequency

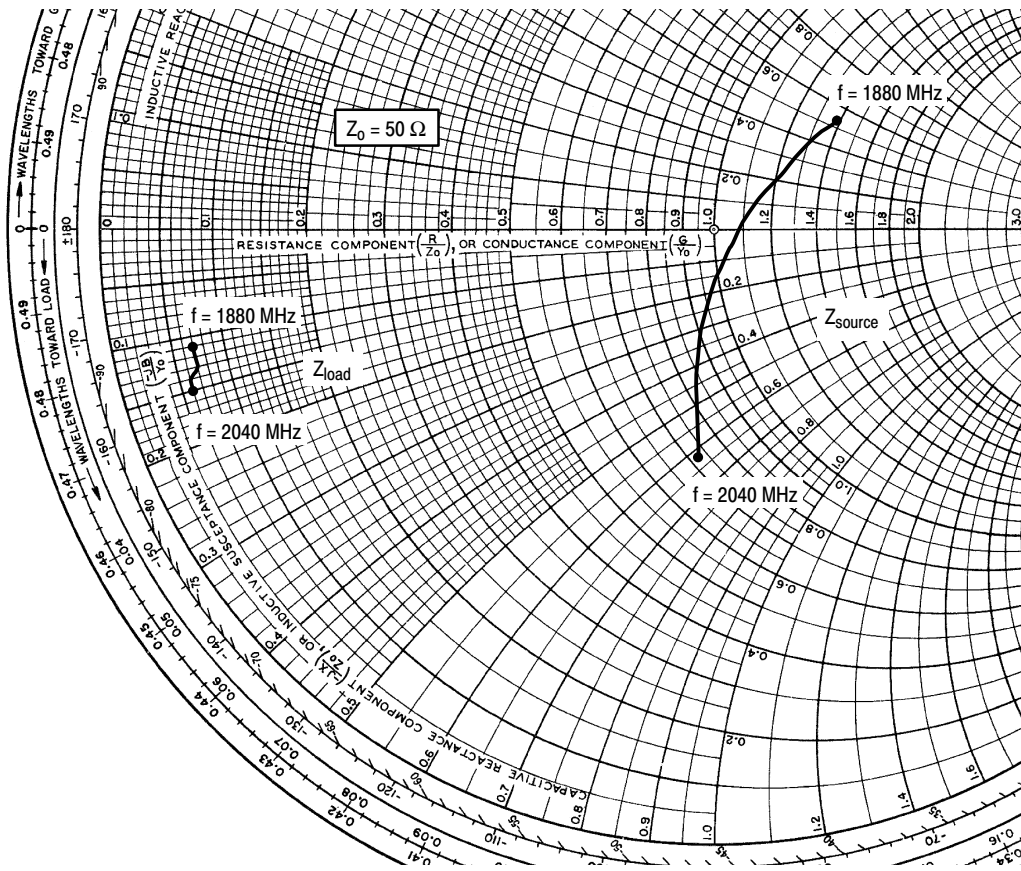


This above graph displays calculated MTTF in hours when the device is operated at $V_{DD} = 28$ Vdc, $P_{out} = 4.5$ W Avg., and $PAE = 13.5\%$.

MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.

Figure 19. MTTF versus Junction Temperature

MW6IC1940NBR1 MW6IC1940GNBR1



$V_{DD} = 28 \text{ Vdc}$, $I_{DQ1} = 200 \text{ mA}$, $I_{DQ2} = 440 \text{ mA}$, $P_{out} = 4.5 \text{ W Avg.}$

| f MHz | Z_{source} Ω | Z_{load} Ω |
|----------|--------------------------|------------------------|
| 1880 | $69.33 + j26.65$ | $3.65 - j5.717$ |
| 1900 | $65.20 + j19.39$ | $3.55 - j5.95$ |
| 1920 | $61.07 + j12.13$ | $3.45 - j6.18$ |
| 1940 | $56.93 + j4.87$ | $3.35 - j6.42$ |
| 1960 | $52.80 - j2.39$ | $3.25 - j6.65$ |
| 1980 | $48.67 - j9.65$ | $3.15 - j6.88$ |
| 2000 | $44.53 - j16.91$ | $3.05 - j7.12$ |
| 2020 | $40.40 - j24.17$ | $2.95 - j7.35$ |
| 2040 | $36.27 - j31.43$ | $2.85 - j7.583$ |

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

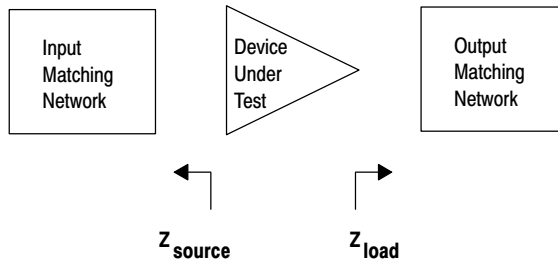


Figure 20. Series Equivalent Source and Load Impedance

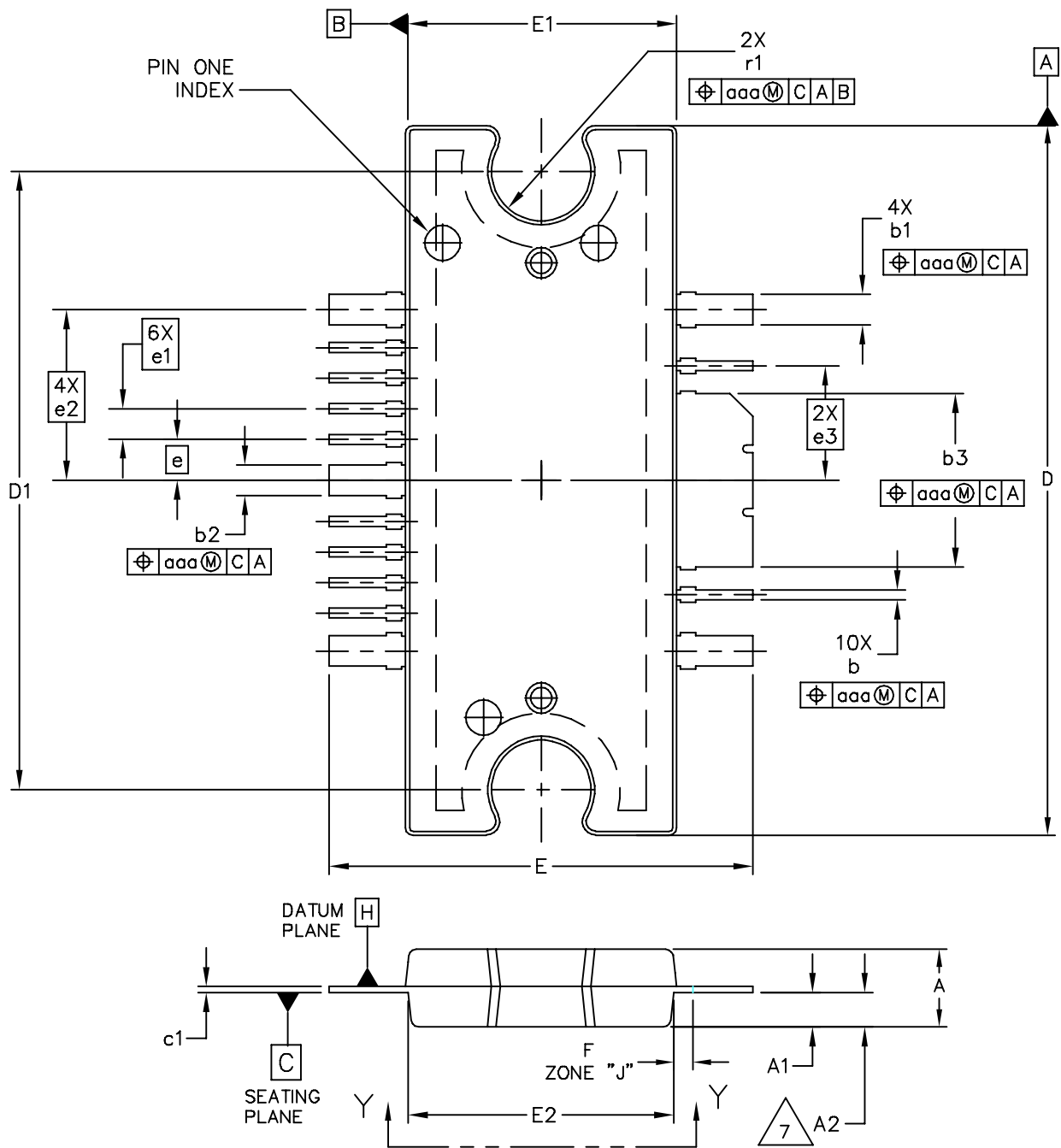
Table 7. Common Source Scattering Parameters ($V_{DD} = 28\text{ V}$, $I_{DQ1} = 200\text{ mA}$, $I_{DQ2} = 440\text{ mA}$, $T_C = 25^\circ\text{C}$, 50 ohm system)

| f MHz | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|----------|-----------------|------|-----------------|------|-----------------|-----|-----------------|------|
| | S ₁₁ | ∠ φ | S ₂₁ | ∠ φ | S ₁₂ | ∠ φ | S ₂₂ | ∠ φ |
| 1.00 | 0.196 | -167 | 0.014 | -146 | 0.001 | 67 | 0.994 | 172 |
| 1.05 | 0.331 | -176 | 0.026 | -164 | 0.001 | 79 | 0.991 | 172 |
| 1.10 | 0.419 | 170 | 0.041 | 178 | 0.001 | 67 | 0.990 | 171 |
| 1.15 | 0.461 | 157 | 0.057 | 160 | 0.001 | 66 | 0.990 | 170 |
| 1.20 | 0.474 | 145 | 0.068 | 147 | 0.001 | 55 | 0.990 | 169 |
| 1.25 | 0.467 | 134 | 0.084 | 144 | 0.001 | 56 | 0.989 | 168 |
| 1.30 | 0.446 | 122 | 0.116 | 143 | 0.001 | 56 | 0.987 | 167 |
| 1.35 | 0.411 | 109 | 0.171 | 138 | 0.001 | 59 | 0.987 | 166 |
| 1.40 | 0.365 | 94 | 0.256 | 131 | 0.001 | 39 | 0.986 | 165 |
| 1.45 | 0.312 | 78 | 0.384 | 122 | 0.001 | 45 | 0.984 | 164 |
| 1.50 | 0.255 | 56 | 0.580 | 111 | 0.001 | 78 | 0.982 | 163 |
| 1.55 | 0.205 | 29 | 0.879 | 98 | 0.001 | 116 | 0.980 | 161 |
| 1.60 | 0.173 | -6 | 1.345 | 85 | 0.001 | 101 | 0.977 | 159 |
| 1.65 | 0.172 | -45 | 2.121 | 70 | 0.001 | 130 | 0.973 | 157 |
| 1.70 | 0.191 | -80 | 3.478 | 53 | 0.001 | 125 | 0.968 | 153 |
| 1.75 | 0.217 | -110 | 6.197 | 33 | 0.002 | 141 | 0.958 | 147 |
| 1.80 | 0.236 | -144 | 13.515 | 5 | 0.003 | 157 | 0.920 | 130 |
| 1.85 | 0.154 | 136 | 39.126 | -69 | 0.009 | 129 | 0.453 | 23 |
| 1.90 | 0.090 | -117 | 20.507 | -160 | 0.006 | 66 | 0.816 | -159 |
| 1.95 | 0.081 | -143 | 12.215 | 170 | 0.005 | 54 | 0.881 | -178 |
| 2.00 | 0.026 | -151 | 9.054 | 147 | 0.003 | 47 | 0.892 | 175 |
| 2.05 | 0.049 | -31 | 7.340 | 126 | 0.003 | 48 | 0.894 | 172 |
| 2.10 | 0.119 | -31 | 6.199 | 105 | 0.002 | 41 | 0.895 | 170 |
| 2.15 | 0.198 | -42 | 5.298 | 85 | 0.002 | 57 | 0.895 | 169 |
| 2.20 | 0.270 | -52 | 4.537 | 66 | 0.002 | 60 | 0.896 | 168 |
| 2.25 | 0.334 | -61 | 3.875 | 47 | 0.002 | 66 | 0.899 | 167 |
| 2.30 | 0.391 | -70 | 3.282 | 29 | 0.002 | 68 | 0.905 | 167 |
| 2.35 | 0.441 | -78 | 2.771 | 13 | 0.002 | 75 | 0.913 | 166 |
| 2.40 | 0.485 | -85 | 2.330 | -3 | 0.002 | 74 | 0.921 | 166 |
| 2.45 | 0.523 | -92 | 1.965 | -17 | 0.002 | 73 | 0.930 | 165 |
| 2.50 | 0.557 | -97 | 1.661 | -31 | 0.002 | 67 | 0.937 | 165 |
| 2.55 | 0.587 | -103 | 1.413 | -43 | 0.002 | 73 | 0.944 | 164 |
| 2.60 | 0.617 | -109 | 1.213 | -55 | 0.003 | 76 | 0.950 | 163 |
| 2.65 | 0.643 | -114 | 1.044 | -66 | 0.002 | 76 | 0.955 | 162 |
| 2.70 | 0.665 | -119 | 0.905 | -77 | 0.003 | 78 | 0.959 | 162 |
| 2.75 | 0.687 | -124 | 0.789 | -88 | 0.003 | 75 | 0.961 | 161 |
| 2.80 | 0.706 | -129 | 0.693 | -99 | 0.003 | 74 | 0.963 | 160 |
| 2.85 | 0.723 | -134 | 0.610 | -109 | 0.003 | 74 | 0.966 | 160 |
| 2.90 | 0.737 | -139 | 0.538 | -120 | 0.003 | 78 | 0.967 | 159 |
| 2.95 | 0.751 | -143 | 0.475 | -130 | 0.003 | 79 | 0.969 | 158 |

**Table 7. Common Source Scattering Parameters ($V_{DD} = 28\text{ V}$, $I_{DQ1} = 200\text{ mA}$, $I_{DQ2} = 440\text{ mA}$, $T_C = 25^\circ\text{C}$, 50 ohm system)
(continued)**

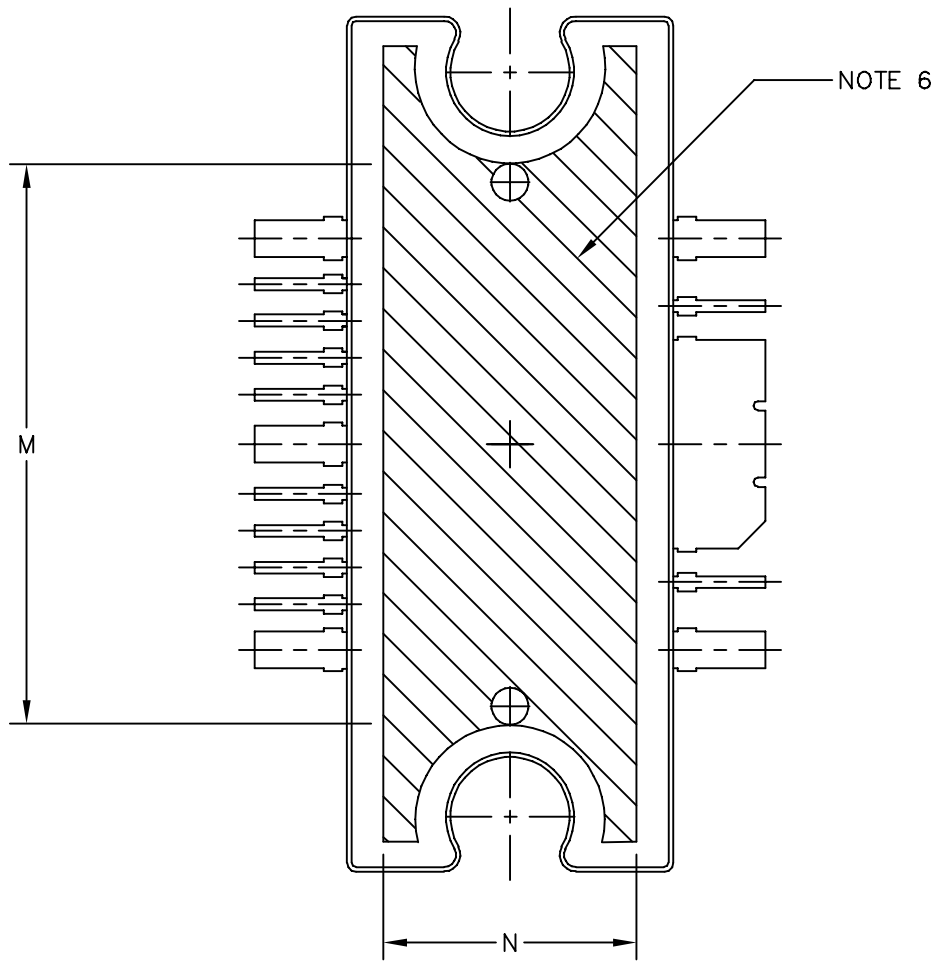
| f MHz | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | |
|----------|-----------------|------|-----------------|------|-----------------|-----|-----------------|-----|
| | S ₁₁ | ∠ φ | S ₂₁ | ∠ φ | S ₁₂ | ∠ φ | S ₂₂ | ∠ φ |
| 3.00 | 0.763 | -147 | 0.418 | -141 | 0.003 | 80 | 0.968 | 158 |
| 3.05 | 0.774 | -152 | 0.367 | -152 | 0.004 | 75 | 0.969 | 157 |
| 3.10 | 0.785 | -156 | 0.319 | -162 | 0.004 | 80 | 0.966 | 157 |
| 3.15 | 0.796 | -159 | 0.278 | -173 | 0.004 | 75 | 0.967 | 156 |
| 3.20 | 0.806 | -163 | 0.239 | 177 | 0.004 | 77 | 0.965 | 156 |
| 3.25 | 0.815 | -166 | 0.206 | 167 | 0.005 | 75 | 0.964 | 155 |
| 3.30 | 0.825 | -170 | 0.176 | 157 | 0.005 | 73 | 0.964 | 155 |
| 3.35 | 0.833 | -173 | 0.151 | 148 | 0.005 | 74 | 0.962 | 154 |
| 3.40 | 0.841 | -176 | 0.128 | 140 | 0.005 | 71 | 0.961 | 154 |
| 3.45 | 0.849 | -178 | 0.110 | 132 | 0.005 | 71 | 0.958 | 153 |
| 3.50 | 0.856 | 179 | 0.095 | 125 | 0.005 | 65 | 0.957 | 153 |
| 3.55 | 0.864 | 177 | 0.081 | 117 | 0.005 | 63 | 0.955 | 152 |
| 3.60 | 0.872 | 174 | 0.070 | 111 | 0.006 | 66 | 0.952 | 152 |
| 3.65 | 0.877 | 172 | 0.061 | 104 | 0.006 | 60 | 0.950 | 151 |
| 3.70 | 0.885 | 170 | 0.053 | 99 | 0.006 | 61 | 0.946 | 151 |
| 3.75 | 0.891 | 169 | 0.047 | 93 | 0.006 | 57 | 0.943 | 150 |
| 3.80 | 0.898 | 167 | 0.041 | 89 | 0.006 | 57 | 0.941 | 150 |
| 3.85 | 0.902 | 166 | 0.037 | 84 | 0.006 | 52 | 0.938 | 149 |
| 3.90 | 0.911 | 164 | 0.033 | 80 | 0.006 | 55 | 0.934 | 149 |
| 3.95 | 0.915 | 163 | 0.030 | 76 | 0.007 | 54 | 0.932 | 148 |
| 4.00 | 0.921 | 162 | 0.028 | 72 | 0.007 | 55 | 0.928 | 148 |

PACKAGE DIMENSIONS



| | | | | |
|---|------------------------------------|--|---|-----------------------|
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| | TITLE: TO-272 WIDE BODY MULTI-LEAD | | DOCUMENT NO: 98ARH99164A CASE NUMBER: 1329-09 STANDARD: NON-JEDEC | REV: L 13 MAR 2006 |

MW6IC1940NBR1 MW6IC1940GNBR1



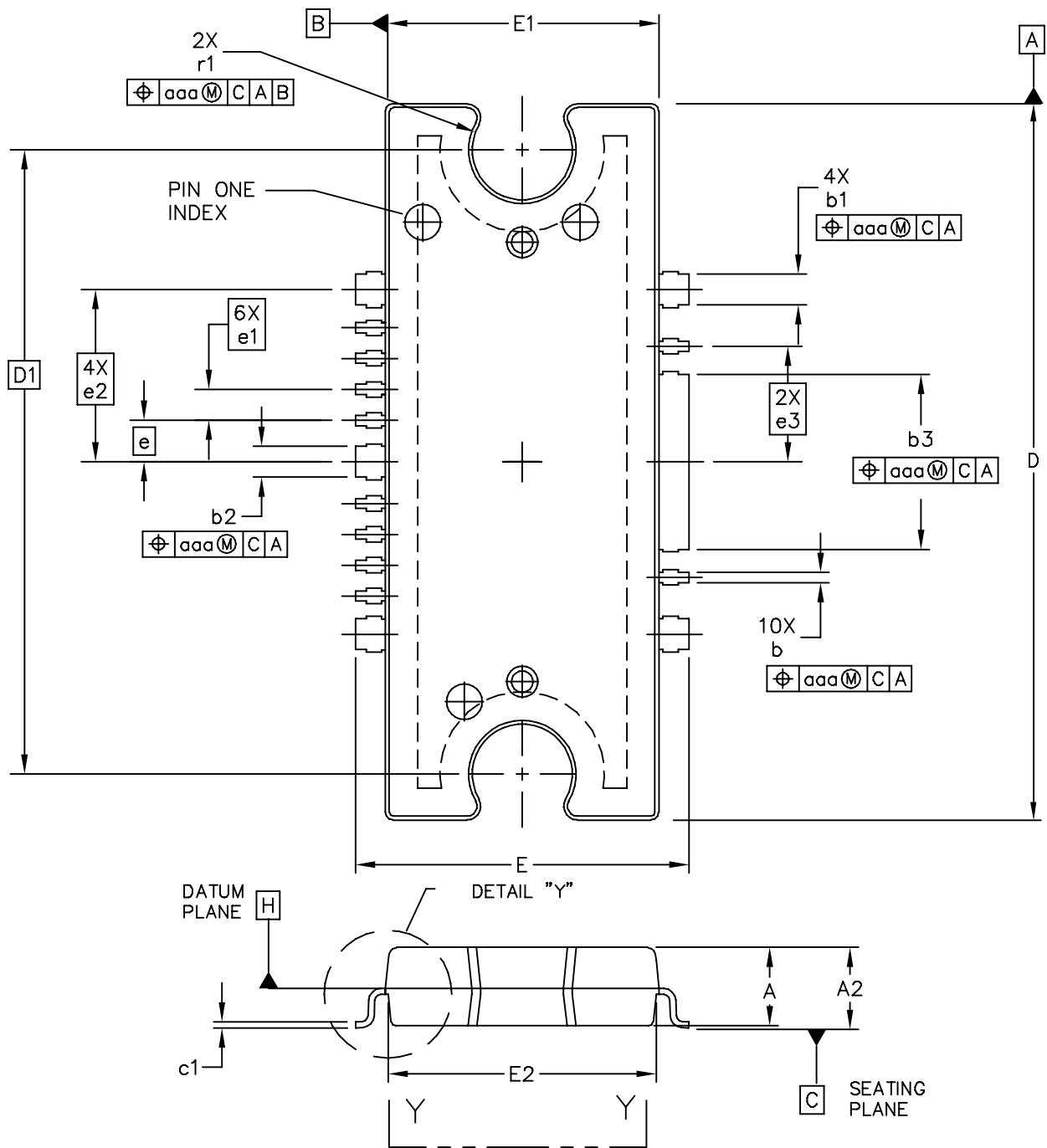
VIEW Y-Y

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| TITLE: TO-272 WIDE BODY MULTI-LEAD | DOCUMENT NO: 98ARH99164A | REV: L | |
| | CASE NUMBER: 1329-09 | 13 MAR 2006 | |
| | STANDARD: NON-JEDEC | | |

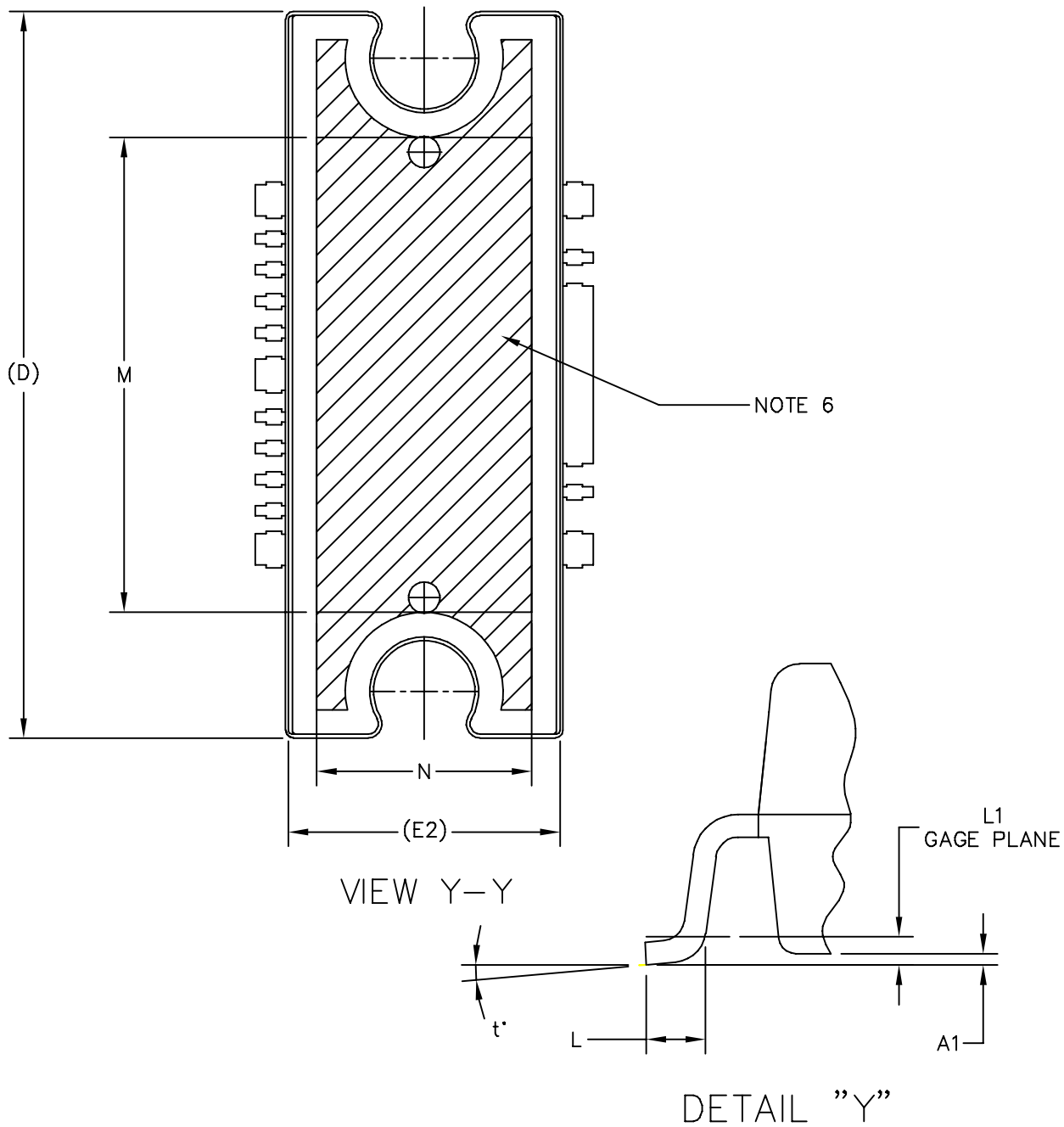
NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.
7. DIM A2 APPLIES WITHIN ZONE "J" ONLY.

| DIM | INCH | | MILLIMETER | | DIM | INCH | | MILLIMETER | |
|---|----------|------|---------------------------|-------|--------------------------|----------------------------|------|-------------|------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| A | .100 | .104 | 2.54 | 2.64 | b | .011 | .017 | 0.28 | 0.43 |
| A1 | .038 | .044 | 0.96 | 1.12 | b1 | .037 | .043 | 0.94 | 1.09 |
| A2 | .040 | .042 | 1.02 | 1.07 | b2 | .037 | .043 | 0.94 | 1.09 |
| D | .928 | .932 | 23.57 | 23.67 | b3 | .225 | .231 | 5.72 | 5.87 |
| D1 | .810 BSC | | 20.57 BSC | | c1 | .007 | .011 | .18 | .28 |
| E | .551 | .559 | 14.00 | 14.20 | e | .054 BSC | | 1.37 BSC | |
| E1 | .353 | .357 | 8.97 | 9.07 | e1 | .040 BSC | | 1.02 BSC | |
| E2 | .346 | .350 | 8.79 | 8.89 | e2 | .224 BSC | | 5.69 BSC | |
| F | .025 BSC | | 0.64 BSC | | e3 | .150 BSC | | 3.81 BSC | |
| M | .600 | ---- | 15.24 | ---- | r1 | .063 | .068 | 1.6 | 1.73 |
| N | .270 | ---- | 6.86 | ---- | aaa | .004 | | .10 | |
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| TITLE: TO-272 WIDE BODY MULTI-LEAD | | | | | DOCUMENT NO: 98ARH99164A | | | REV: L | |
| | | | | | CASE NUMBER: 1329-09 | | | 13 MAR 2006 | |
| | | | | | STANDARD: NON-JEDEC | | | | |



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|---|---------------------------|----------------------------|--|
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| TITLE: TO-272WB, 16 LEAD GULL WING PLASTIC | DOCUMENT NO: 98ASA10532D | REV: E | |
| | CASE NUMBER: 1329A-03 | 3 APR 2006 | |
| | STANDARD: NON-JEDEC | | |



| | | | |
|---|---------------------------|----------------------------|--|
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| TITLE: TO-272WB, 16 LEAD GULL WING PLASTIC | DOCUMENT NO: 98ASA10532D | REV: E | |
| | CASE NUMBER: 1329A-03 | 3 APR 2006 | |
| | STANDARD: NON-JEDEC | | |

MW6IC1940NBR1 MW6IC1940GNBR1

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 (0.15) PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
5. DIMENSIONS "b", "b1", "b2" AND "b3" DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 (0.13) TOTAL IN EXCESS OF THE "b", "b1", "b2" AND "b3" DIMENSIONS AT MAXIMUM MATERIAL CONDITION.
6. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

| DIM | INCH | | MILLIMETER | | DIM | INCH | | MILLIMETER | |
|-----|----------|------|------------|-------|-----|----------|------|------------|------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| A | .100 | .104 | 2.54 | 2.64 | b | .011 | .017 | 0.28 | 0.43 |
| A1 | .001 | .004 | 0.02 | 0.10 | b1 | .037 | .043 | 0.94 | 1.09 |
| A2 | .099 | .110 | 2.51 | 2.79 | b2 | .037 | .043 | 0.94 | 1.09 |
| D | .928 | .932 | 23.57 | 23.67 | b3 | .225 | .231 | 5.72 | 5.87 |
| D1 | .810 BSC | | 20.57 BSC | | c1 | .007 | .011 | .18 | .28 |
| E | .429 | .437 | 10.9 | 11.1 | e | .054 BSC | | 1.37 BSC | |
| E1 | .353 | .357 | 8.97 | 9.07 | e1 | .040 BSC | | 1.02 BSC | |
| E2 | .346 | .350 | 8.79 | 8.89 | e2 | .224 BSC | | 5.69 BSC | |
| L | .018 | .024 | 4.90 | 5.06 | e3 | .150 BSC | | 3.81 BSC | |
| L1 | .01 BSC | | .025 BSC | | r1 | .063 | .068 | 1.6 | 1.73 |
| M | .600 | ---- | 15.24 | ---- | t | 2' | 8' | 2' | 8' |
| N | .270 | ---- | 6.86 | ---- | aaa | .004 | | .10 | |

| | | | | | |
|---|--|---------------------------|--------------------------|----------------------------|------------|
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| TITLE: TO-272WB, 16 LEAD GULL WING PLASTIC | | | DOCUMENT NO: 98ASA10532D | | REV: E |
| | | | CASE NUMBER: 1329A-03 | | 3 APR 2006 |
| | | | STANDARD: NON-JEDEC | | |

PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN1977: Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN3263: Bolt Down Mounting Method for High Power RF Transistors and RFICs in Over-Molded Plastic Packages

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date | Description |
|----------|-----------|---|
| 0 | Nov. 2006 | <ul style="list-style-type: none">• Initial Release of Data Sheet |
| 1 | Jan. 2007 | <ul style="list-style-type: none">• Updated verbiage on Typical Performances table, p. 2• Updated Part Numbers in Table 6, Component Designations and Values, to RoHS compliant part numbers, p. 3• Added new Figure 13, Pulsed CW Output Power versus Input Power, p. 6• Added new Figure 18, Power Gain versus Frequency, p. 7• Replaced Figure 19, MTTF versus Junction Temperature with updated graph. Removed Amps² and listed operating characteristics and location of MTTF calculator for device, p. 7• Updated Product Documentation adding AN1907 and AN3263, p. 17 |

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